

STARPOWER

SEMICONDUCTOR

SiC MOSFET

MD16HTS75P6HET

750V/1.60mΩ 6 in one-package

General Description

STARPOWER MOSFET Power Module provides very low $R_{DS(on)}$ as well as optimized intrinsic diode. It's designed for the applications such as hybrid and electric vehicle.

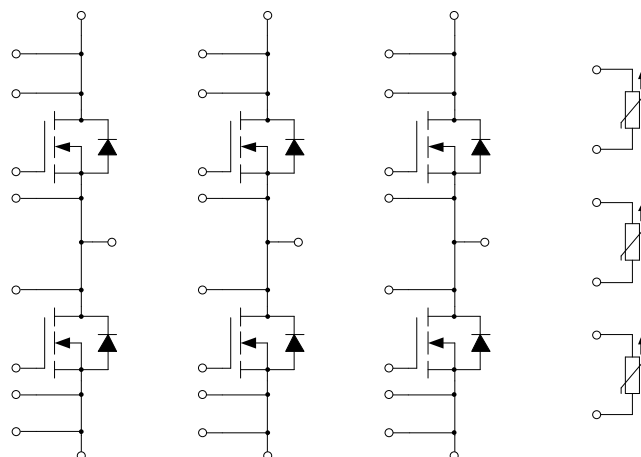
Features

- SiC power MOSFET
- High blocking voltage with low $R_{DS(on)}$
- Easy to parallel and simple to drive
- Low inductance case avoid oscillations
- Isolated copper pinfin baseplate using Si_3N_4 AMB technology

Typical Applications

- Automotive application
- Hybrid and electric vehicle
- Inverter for motor drive

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_F=25^{\circ}\text{C}$ unless otherwise noted**MOSFET**

Symbol	Description	Value	Unit
V_{DSS}	Drain-Source Voltage	750	V
V_{GSSmax}	Gate-Source Voltage	-8/+19	V
V_{GSSop}	Gate-Source Voltage	-4/+15	V
I_D	Drain Curren @ $T_F=75^{\circ}\text{C}$	660	A
I_{DRM}	Repetitive Peak Drain Current $t_p=1\text{ms}$	1320	A
P_D	Maximum Power Dissipation @ $T_F=75^{\circ}\text{C}$ $T_{vj}=175^{\circ}\text{C}$	977	W

Body Diode

Symbol	Description	Value	Unit
I_S	Source Current @ $T_F=75^{\circ}\text{C}$	250	A

Module

Symbol	Description	Value	Unit
T_{vjmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{vjop}	Operating Junction Temperature	-40 to +175	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	2500	V

MOSFET Characteristics $T_F=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$R_{DS(on)}$	Static Drain-Source On-Resistance	$I_D=628\text{A}, V_{GS}=15\text{V}, T_{vj}=25^{\circ}\text{C}$		1.60	2.25	$\text{m}\Omega$
		$I_D=628\text{A}, V_{GS}=15\text{V}, T_{vj}=150^{\circ}\text{C}$		1.73	2.56	
		$I_D=628\text{A}, V_{GS}=15\text{V}, T_{vj}=175^{\circ}\text{C}$		1.83	2.75	
$V_{GS(th)}$	Gate-Source Threshold Voltage	$I_D=176\text{mA}, V_{DS}=V_{GS}, T_{vj}=25^{\circ}\text{C}$	1.8	2.5	3.2	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=V_{DSS}, V_{GS}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			500	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=15\text{V}, V_{DS}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			600	nA
R_{Gint}	Internal Gate Resistance			0.79		Ω
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=750\text{V}, f=100\text{kHz}$		48.8		nF
C_{oss}	Output Capacitance			1.92		nF
C_{rss}	Reverse Transfer Capacitance			0.13		nF
Q_g	Total Gate Charge	$I_D=628\text{A}, V_{DS}=470\text{V}, V_{GS}=-4/+15\text{V}$		1.52		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=450\text{V}, I_D=680\text{A}, R_{Gon}=6.8\Omega, L_S=25\text{nH}, V_{GS}=-4/+15\text{V}, T_{vj}=25^{\circ}\text{C}$		225		ns
t_r	Rise Time			122		ns
$t_{d(off)}$	Turn-Off Delay Time			475		ns
t_f	Fall Time			83		ns
E_{on}	Turn-On Switching Loss			21.1		mJ
E_{off}	Turn-Off Switching Loss			33.9		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=450\text{V}, I_D=680\text{A}, R_{Gon}=6.8\Omega, L_S=25\text{nH}, V_{GS}=-4/+15\text{V}, T_{vj}=150^{\circ}\text{C}$		231		ns
t_r	Rise Time			135		ns
$t_{d(off)}$	Turn-Off Delay Time			592		ns
t_f	Fall Time			99		ns
E_{on}	Turn-On Switching Loss			22.9		mJ
E_{off}	Turn-Off Switching Loss			37.9		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=450\text{V}, I_D=680\text{A}, R_{Gon}=6.8\Omega, L_S=25\text{nH}, V_{GS}=-4/+15\text{V}, T_{vj}=175^{\circ}\text{C}$		235		ns
t_r	Rise Time			136		ns
$t_{d(off)}$	Turn-Off Delay Time			623		ns
t_f	Fall Time			100		ns
E_{on}	Turn-On Switching Loss			23.1		mJ
E_{off}	Turn-Off Switching Loss			39.4		mJ

Body Diode Characteristics $T_F=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_{SD}	Diode Forward Voltage	$I_S=320\text{A}, V_{GS}=-4\text{V}, T_{vj}=25^{\circ}\text{C}$		4.45		V
		$I_S=320\text{A}, V_{GS}=-4\text{V}, T_{vj}=150^{\circ}\text{C}$		4.00		
		$I_S=320\text{A}, V_{GS}=-4\text{V}, T_{vj}=175^{\circ}\text{C}$		3.95		
t_{rr}	Reverse Recovery Time	$V_R=450\text{V}, I_F=680\text{A}, -di/dt=5590\text{A}/\mu\text{s}, L_S=25\text{nH}, V_{GE}=-4\text{V}, T_{vj}=25^{\circ}\text{C}$		43		ns
Q_r	Recovered Charge			3.00		μC
I_{RM}	Peak Reverse Recovery Current			100		A
E_{rec}	Reverse Recovery Energy			0.30		mJ
t_{rr}	Reverse Recovery Time	$V_R=450\text{V}, I_F=680\text{A}, -di/dt=5660\text{A}/\mu\text{s}, L_S=25\text{nH}, V_{GE}=-4\text{V}, T_{vj}=150^{\circ}\text{C}$		48		ns
Q_r	Recovered Charge			4.07		μC
I_{RM}	Peak Reverse Recovery Current			126		A
E_{rec}	Reverse Recovery Energy			0.46		mJ
t_{rr}	Reverse Recovery Time	$V_R=450\text{V}, I_F=680\text{A}, -di/dt=5710\text{A}/\mu\text{s}, L_S=25\text{nH}, V_{GE}=-4\text{V}, T_{vj}=175^{\circ}\text{C}$		50		ns
Q_r	Recovered Charge			4.57		μC
I_{RM}	Peak Reverse Recovery Current			138		A
E_{rec}	Reverse Recovery Energy			0.55		mJ

NTC Characteristics $T_F=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			5.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_{vj}=100^{\circ}\text{C}, R_{100}=493.3\Omega$	-5		5	%
P_{25}	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Module Characteristics $T_F=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
L_{CE}	Stray Inductance		8		nH
$R_{CC'+EE'}$	Module Lead Resistance, Terminal to Chip		0.43		m Ω
p	Maximum Pressure In Cooling Circuit			2.5	bar
R_{thJF}	Junction-to-Cooling Fluid (per MOSFET) $\Delta V/\Delta t=10.0\text{dm}^3/\text{min}, T_F=75^{\circ}\text{C}$		0.093		K/W
M	Terminal Connection Torque, Screw M5 Mounting Torque, Screw M4	3.6 1.8		4.4 2.2	N.m
G	Weight of Module		750		g

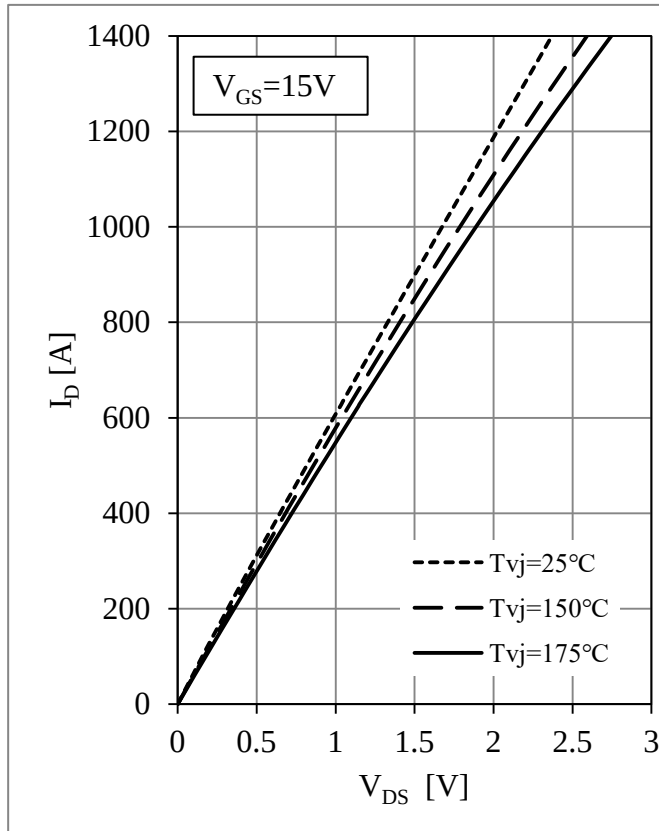


Fig 1. MOSFET Output Characteristics

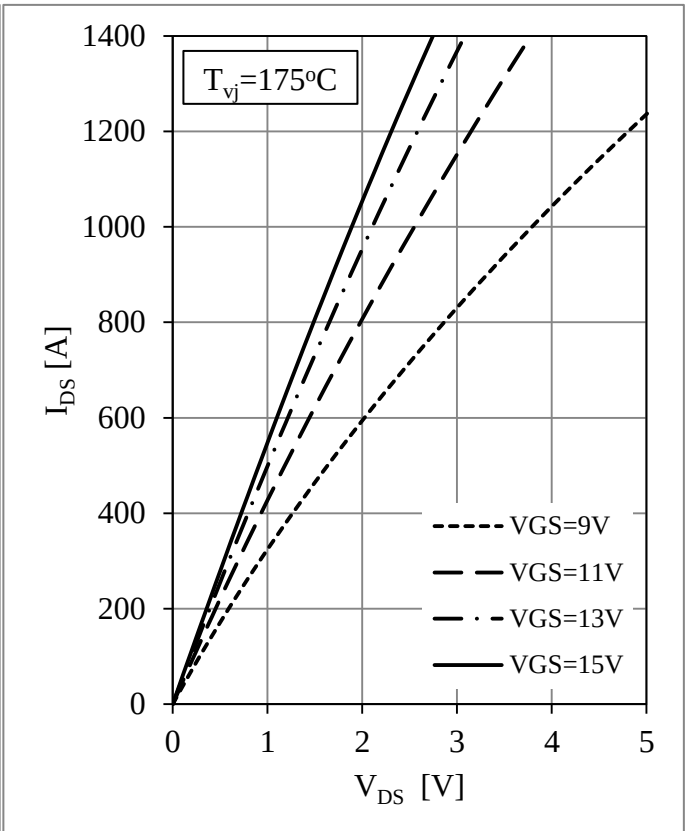


Fig 2. MOSFET Output Characteristics

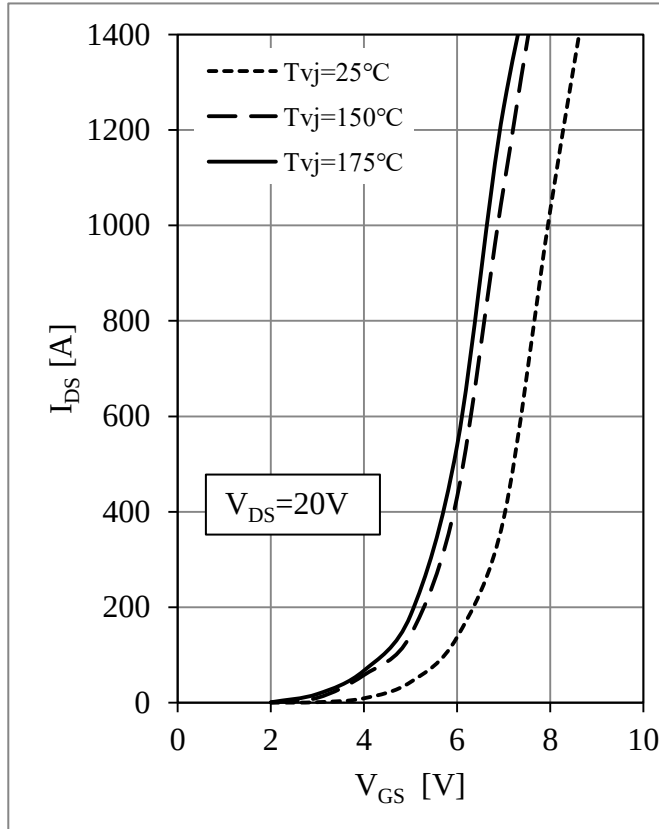
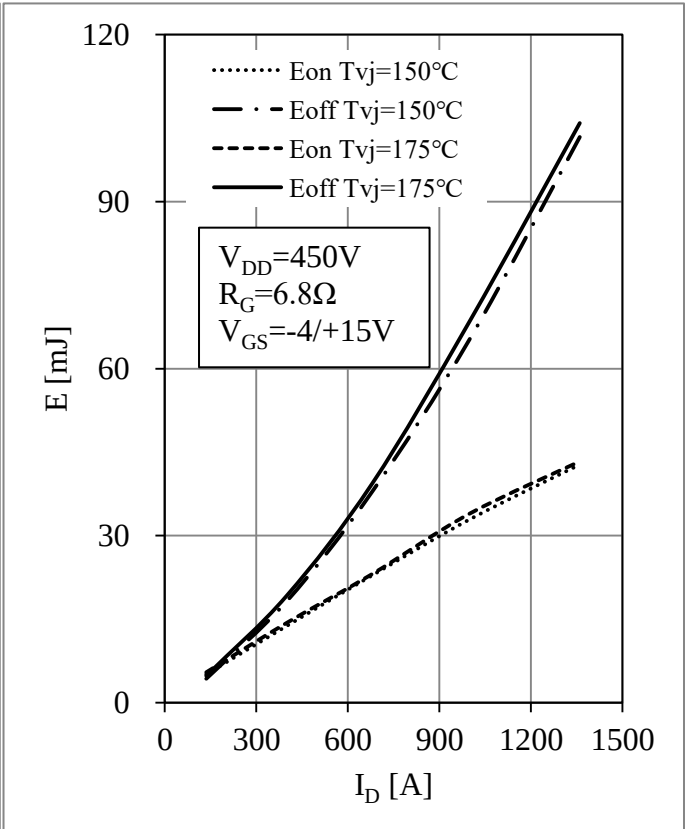
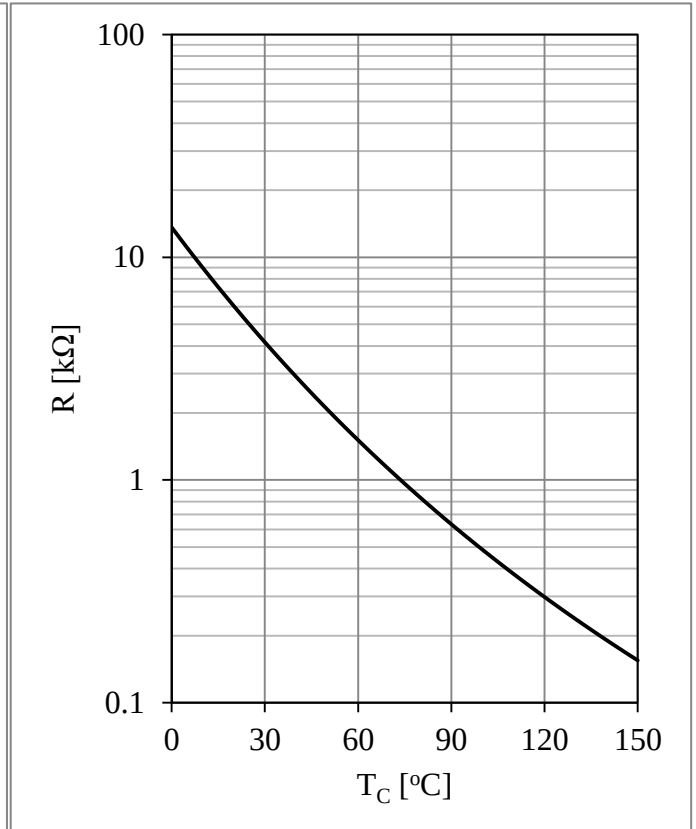
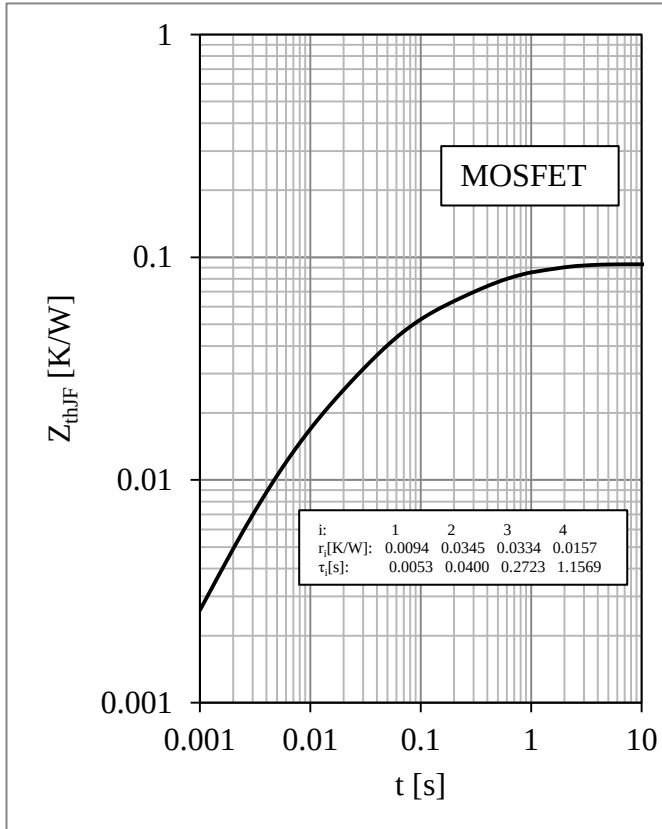
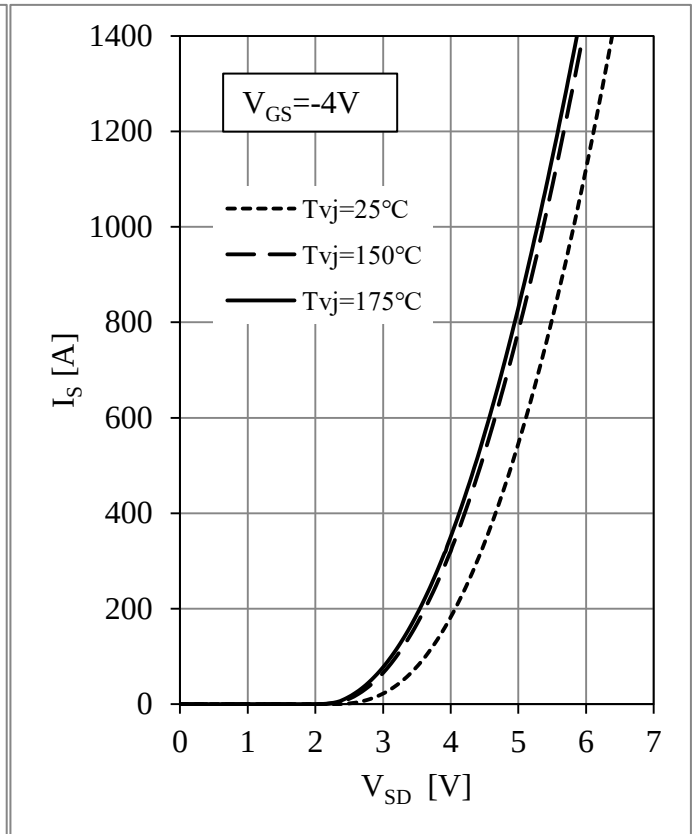
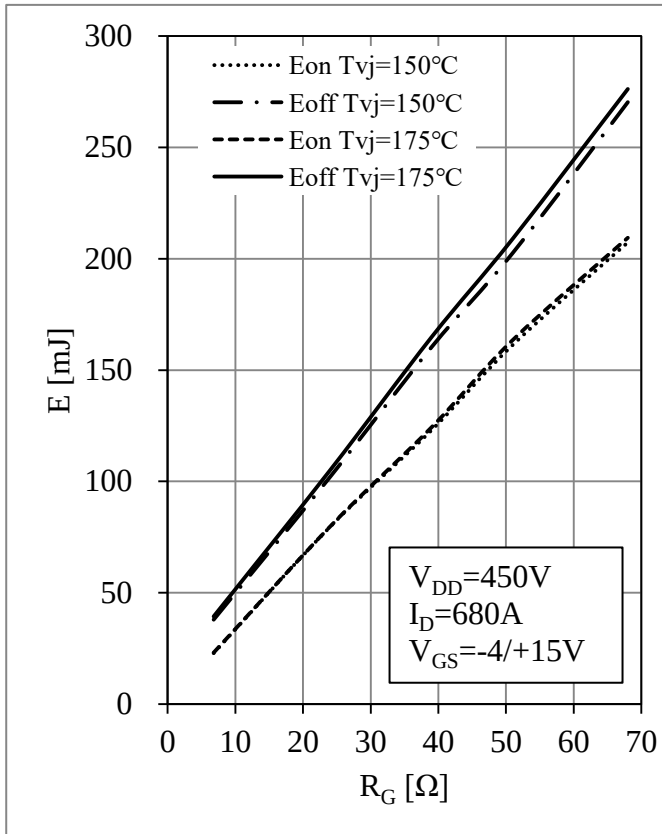
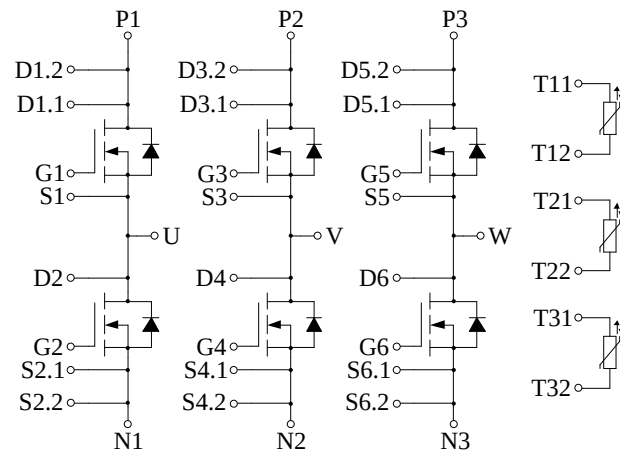


Fig 3. MOSFET Transfer Characteristics

Fig 4. MOSFET Switching Loss vs. I_{DS}

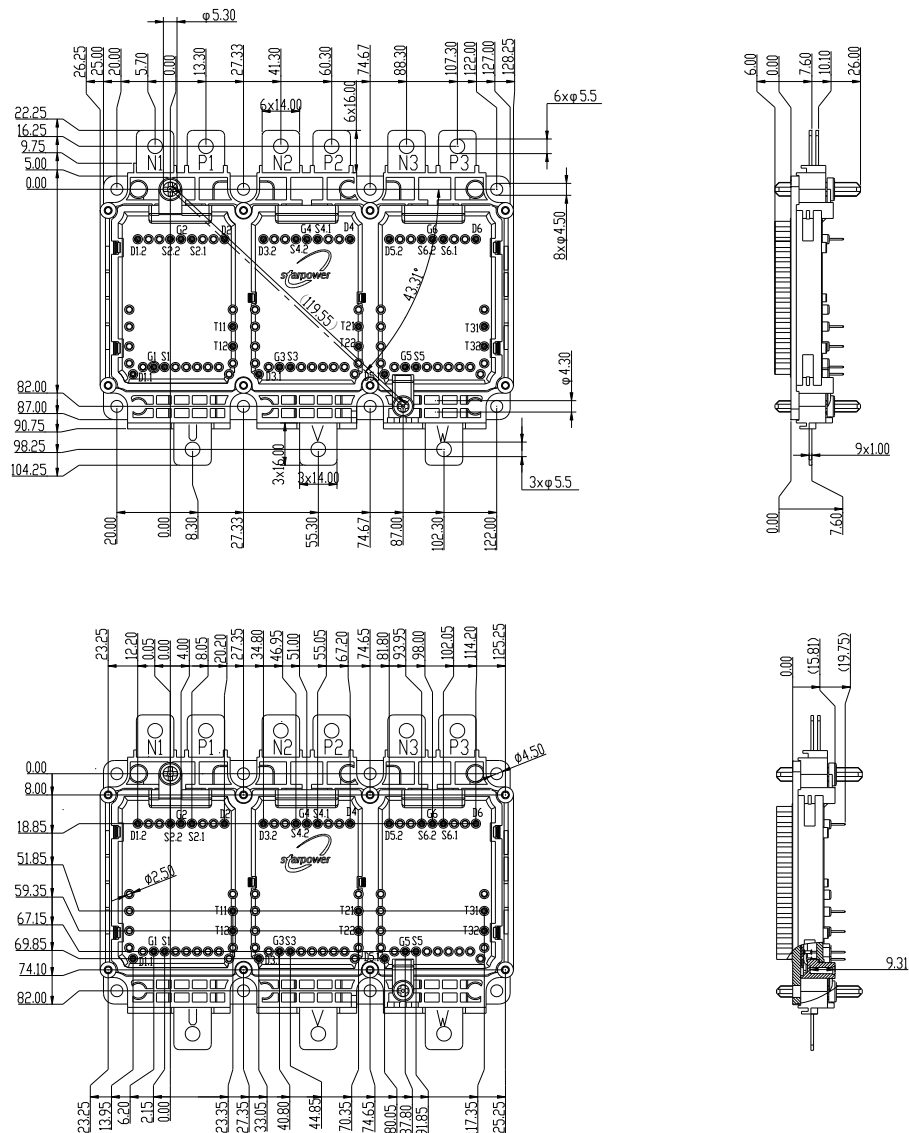


Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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